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| Notice of References Cited | Application/Control No. 10/511,815 | Applicant(s)/Patent Under Reexamination KOPRA ET AL. | |
| | Examiner Zhiyu Lu | Art Unit 2618 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-6,658,231 | 12-2003 | Nakatsuyama, Takashi | 455/3.06 |
| * | B | US-6,678,510 | 01-2004 | Syrjarinne et al. | 455/255 |
| * | C | US-7,031,696 | 04-2006 | Gerrits et al. | 455/414.1 |
| * | D | US-2003/0069033 | 04-2003 | Edge et al. | 455/502 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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